		APPLICATION FOR EXTEN	ISION OF ESCC QU	JALIFICATION APPROVAL	Page 1		
E	SCC		BIPOLAR LOW ANI	ND HIGH POWER SINGLE DUAL			
Test of the		Executive Member: CNES		Date: 05/11/2020	361A		
Components (includi	ing series and families) submitted for Extension of Qualificati	ion Approval:		_ 1_		
ESCC COMPONENT NO.	VARIANTS	RANGE OF COMPONENTS	BASED ON	TEST VEHICLE / S	COMPONENT SIMILAR		
5201/001 5201/002 5201/019 5201/004	04, 05, 06, 07 04, 05, 11, 12 04, 05, 08, 09 04, 05, 06, 07	LCC3, LCC3+1 LCC3, LCC3+1 LCC3, LCC3+1 LCC3, LCC3+1 LCC3, LCC3+1	2N 2484 2N 222AA 2N 5551 2N 3700	2N5154HRG 2N2222ARUBG			
5203/010 5203/016 5207/002 5201/020	04, 05, 06, 07 06, 07, 12, 15, 16, 17 01	TO-257, SMD.5 TO-257 LCC6, FP8 SMD.5	2N 5154 BUX77ESY 2N 2920A 2ST15300				
5202/001 5202/014 5204/002 5204/006 5207/005	04, 05, 06, 07 04, 05, 06, 07 04, 05, 06, 07 06, 07 07,09 10, 11	LCC3, LCC3+1 LCC3, LCC3+1 TO-257, SMD.5 TO-257 LCC6, FP8	2N 2907A 2N 5401 2N 5153 BUX78ESY 2N 3810	2N3810KT 2N5153SYHRG 2N5153SHRG			
5207/009	01,02	FP8	2ST 3360	2ST3360RKT	ĺ		
Component M	anufacturer 2	2 Location of Manufacturing F			4		
STMicroelectronics		3, rue de Suisse BP4199, 35041	Rennes Cedex	Date of original qualification ap Date: 15/07/2019 Certificate Ref No. 361	proval:		
ESCC Specifications Maintenance of quali Generic: 5000 Detail(s): 5201/00 5201/01 5203/01 5203/01 5203/01 5202/00 5202/00 5202/00 5202/00 5207/00 5207/00 5207/00	Issue: 7 01 Issue: 7 02 9 09 9 04 8 00 9 04 8 00 9 04 8 00 9 06 6 02 9 00 2 01 9 02 5 06 6 02 5 03 8 09 4	Deviations to LVT testing and Derused: No ⊠ Yes □ (support 15) Deviation from current Specification No ⊠ Yes □ (support 15) Deviation from current Specification No ⊠ Yes □ (Support 15) No ⊠ Yes □ (Support 15) No ⊠ Yes □ (Support 15) tresults during current validity period 100 100 100	ply details in Box ons: ply details)		D39 DC1844) MD.5 DC1851) 8 DC1902) 6 (TO 257 DC1850) (LCC3 DC1948) FP8 DC1927) 8		
PID changes since s None □ Minor* ⊠ Major* □	tart of qualification	Ref No:		JB Sauveplaine, e of Executive Representative A c) & 8124528 (specific Bipolar) I Date:	vgency rev 19 02/07/2020		
Current Manufacturir	ng facilities surveyed b			_	/05/2019 (Doto)		
Satisfactory: Report Reference:	Yes ⊠ <u>CR-Etude SMD</u> 5	No 🗌 Explain	ve Representative A	gunoy)	(Date)		

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL							
ESCC	Component title:		BIPOLAR LOW AND H COMPLEMENTARY NP	IIGH POWER SINGLE DUAL YN/PNP	Appl. No.		
	Executive Member:	CNES		Date: 05/11/2020	361A		
					12		
Failure Analysis, DPA, NCCS ava	ilable: Yes	□ No	☑ (Supply data)				
Ref. No's and purposes:							
The undersigned hereby certifies on behalf that the appropriate documentation has be (except as stated in box 15;) - that the repo CNES as the responsible Executive Membe	en evaluated; - that ful rts and data are availa	l compliance to a able at the ESCC	II ESCC requirements is Executive and therefor	s evidence re applies on behalf of			
Date: 05/11/2020				Vacher Franç	ois		
				(Signature of the Executive	e Coordinator)		
Continuation of Boxes above:					14		

		AP	PLICATION FOR EXTENSION OF ESCC QI	UALIFICATION APPROVAL	Page 3
Contra Contra	ESCC	Componen	t title: TRANSISTOR BIPOLAR LOW AN MATCH AND COMPLEMENTARY		Appl. No.
		Executive N	Member: CNES	Date: 05/11/2020	361A
Non comp	liance to ESCC requirements:				15
No.:	Specification		Paragraph	Non compliance	9
Additional noncompli	tasks required to achieve full co ance:	mpliance for I	ESCC qualification or rationale for acceptabili	ity of	16
Executive	Manager Disposition				17
Application Action / Re		No 🗆		Digitally s by Britta S Date: 2020 18:45:27 +	igned ichade 0.11.25 -01'00'
Date:				B. Schade: Head of the Product and Safety Department	t Assurance

	APPLICAT	Page 4						
ESCC	Component Title:	TRANSISTOR BIPOLAR LOW AND HIGH I MATCH AND COMPLEMENTARY NPN/PN		NGLE DUAL	Appl. No.			
	Executive Member:	CNES	Date:	05/11/2020	361A			
ANNEX 1: LIST OF TESTS DONE TO SUF	PORT EXTENSION	OF QUALIFICATION			18			
Tests conducted in compliance with:								
 ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts); or PID-TFD (for ESCC/QML parts) 								
Tests vehicle identification/description:								
Full F4: 2N5154HRG (TO39 DC1844) 2N5153SHRG (SMD.5 DC1851)	F4 Sg1 8	3: SOC2222AHRG (LCC3 DC1948)						
Full F4: 2N3810RKT (F8D DC1902) F4 Sg2: 2ST3360RKT (FP8 DC1927) 2N5153ESYHRG (TO 257 DC1850) F4 Sg2: 2ST3360RKT (FP8 DC1927)								
Detail Specification reference: Se	e box 5		•					

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock	\boxtimes	MIL-STD-750 TM2016	1844 - 1948	75	0	
	Vibration	\boxtimes	MIL-STD-750 TM2056	1844 - 1948	75	0	
	Constant acceleration	\boxtimes	MIL-STD-750 TM2006	1844 - 1948	75	0	
group	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	1844 - 1948	75	0	
al Sub	Electrical Measurement	\boxtimes	Intermediate and End- Point Electrical Measurements	1844 - 1948	75	0	
Janic	External Visual	\boxtimes	ESCC Basic Spec 20500	1844 - 1948	75	0	
al/Mech	Thermal shock		MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
ment	Temperature Cycling	\boxtimes	MIL-STD-750 TM1051	1844 - 1948	75	0	
Environmental/Mechanical Subgroup	Moisture Resistance	\boxtimes	MIL-STD-750 TM1021	1844 - 1948	75	0	
	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	1844 - 1948	75	0	
	Electrical Measurement	\boxtimes	Intermediate and End- Point Electrical Measurements	1844 - 1948	75	0	
	External Visual	\boxtimes	ESCC Basic Spec 20500	1844 - 1948	75	0	
	Operating Life	\boxtimes	ESCC 5000 Para. 8.19	1844 - 1927	75	0	
Endurance Subgroup	Electrical Measurement	\boxtimes	Intermediate and End- Point Electrical Measurements	1844 - 1927	75	0	
Endu Subç	Seal Fine leak Gross leak	\boxtimes	MIL-STD-750 TM1071	1844 - 1927	75	0	
	External Visual Inspection	\boxtimes	ESCC Basic Spec 20500	1844 - 1927	75	0	
	Permanence of Marking		ESCC Basic Spec 24800				Not applicable on Laser marking
Assembly Capability Subgroup	Terminal Strength	\boxtimes	ESCC 5000 Para. 8.18	1844- 1948	25	0	
	Internal Visual	\boxtimes	ESCC Basic Spec 20400	1844- 1948	25	0	
AS Ca	Bond Strength	\boxtimes	MIL-STD-750 TM 2037	1844- 1948	25	0	
	Die Shear	\boxtimes	MIL-STD-750 TM 2017	1844- 1948	15	0	

a bud	ESCC	Com	APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL Component title: TRANSISTOR BIPOLAR LOW AND HIGH POWER SINGLE DUAL MATCH AND COMPLEMENTARY NPN/PNP					Page 5 Appl. No.		
	199 (A)	Exec	Executive Member: CNES			te: 05/11/2	020	361A		
Ch art F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects		ents if not ormed. on Rejection		
s										
Additional Tests										
Ac										

		1							
		APPLICAT	ON FOR EXTENSION	OF ESCC QUALIFICA	TION APPROVAL	Page 7			
ES	SCC	Component title:		LAR LOW AND HIGH PO LEMENTARY NPN/PNP		Appl. No.			
		Executive Member:	CNES	Date:	05/11/2020	361A			
NOTE	ES ON THE COMPL	ETION OF THE APP	LICATION FORM FOR	ESCC QUALIFICATIO	N EXTENSION APPROVAL	L			
ENTRIES									
Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.								
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.								
Box 2; 3 and 4	As per QPL entry;	otherwise, an explan	ation of the changes m	ust be supplied.					
Box 5					revision letter, current at th ate of the application, see B				
Box 6	deviations this mu	st be listed in Box 15.		specification in Box 5 ha	particular deviations from te ave currently a different issu				
Box 7	Must reference the	e report(s) supplied in	support of the applica	ion.					
Box 8					l of which should already hav opriate table has been draw				
Box 9				st Extension of Qualifica changes shall be clearly	tion, adequate details of suc marked.	ch evolution shall			
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.								
Box 11	practices, procedu	ures, material, etc. use	ed in manufacturing the	components are as desc	unexplained changes occur cribed in the PID. This surve ts findings shall be recorded	y shall be carried			
Box 12		s) (NCCS) occurred of			d Failure Analysis reports established corrective actio				
Box 13	Enter only the na Coordinator.	me of the Executive	Member (i.e., CNES,	DLR, ESTEC, etc.) and	the signature of the respo	nsible Executive			
Box 14				from 1 through 12. Ident everal boxes have to be	tify box affected and referen expanded.	nce the Box 14 in			
Box 15	Fill in Table as rec	quested.							
Box 16				mber to bring the submi s) to accept the noncomp	tted data to a standard likel pliance.	y to be accepted			
Box 17					restrictions, modifications of representative for ESA, and				
Box 18	Fill in Table as rec	quested.							
Box 19			luding those of a confid	lential nature, shall be pi	rovided.				
Box 20		nce with reference to ally numbered. If relev		aragraph(s). To simplify	reference in Box 16 each	nonconformance			
Box 21				mber to bring the submi s) to accept the noncomp	itted data to a standard likel bliance.	y to be accepted			
Box 22	Additional Comme	ents.							